

IEC QUALITY ASSESSMENT SYSTEM (IECQ)

covering Electronic Components, Assemblies, Related Materials and Processes

For rules and details of the IECQ visit www.iecq.org

Schedule of Scope to Certificate of Conformity Approved Process

IECQ Certificate No.: IECQ-L ULTW 09.0023-07
CB Certificate No.: 20005898 ITL

Schedule Number: IECQ-L ULTW 09.0023-07-S Rev No.: 3 Revision Date: 2019/11/25 Page 1 of 2

Appendix-1 (20005898 ITL) Schedule of Scope to Certificate of Approval

Description test	Standard
ICP-OES	13QM100426
GC-MS	13QM100370
	13QM100377
	13QM100442
IC	13QM100422
	13QM100455
FTIR	13QM100015
	13QM100017
Raman	13QM100346
拉曼	
TGA	13QM100018
DSC	13QM100019
Moisture Titrator	13QM100458
水分滴定儀	13QM100460
Titration meter	13QM100459
滴定儀	
Melting point apparatus	13QM100457
熔點分析儀	
Viscometer	13QM100028
黏度	
Spectrophotometer	13QM100451
分光色差儀	
3D laser Scanning microscope	13QM100354
3D 雷射掃描顯微鏡	
Pencil hardness tester	13QM100388
鉛筆硬度計	
Vertical bending measuring instrument	13QM100584
立式翹曲量測機	
DUH (Dynamic ultra hardness tester)	12OM100390
DUH超微小動態硬度機	13QM100389
SAT (Scanning acoustic tomography)	13QM100352
Friction meter	13QM100585
磨擦係數量測儀	13001100000

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Description test	Standard
abrasion tester 磨耗測試機	13QM100766
UV-VIS	13QM100454

Technical Reviewer of DQS: Michael Chou Date: 11/25/2019



